



10/01/2021

Measurement of the Higgs Simplified Template Cross Sections using $H \rightarrow \gamma\gamma$ decays with the ATLAS experiment

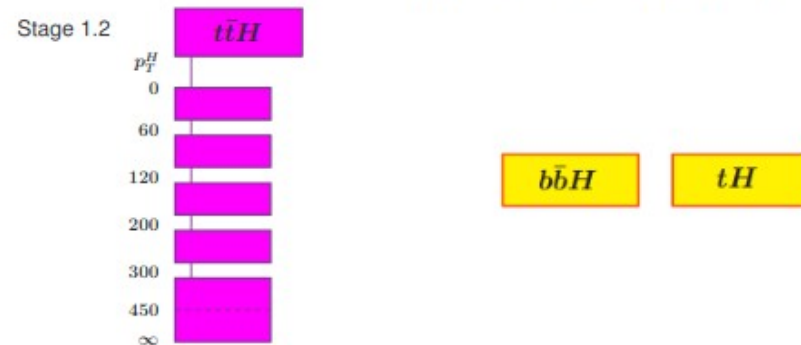
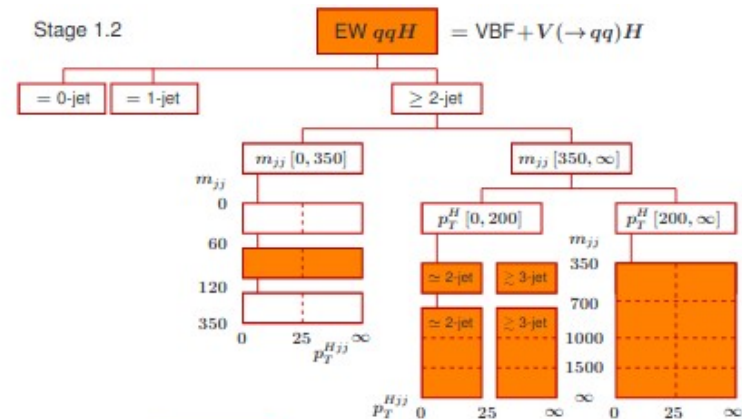
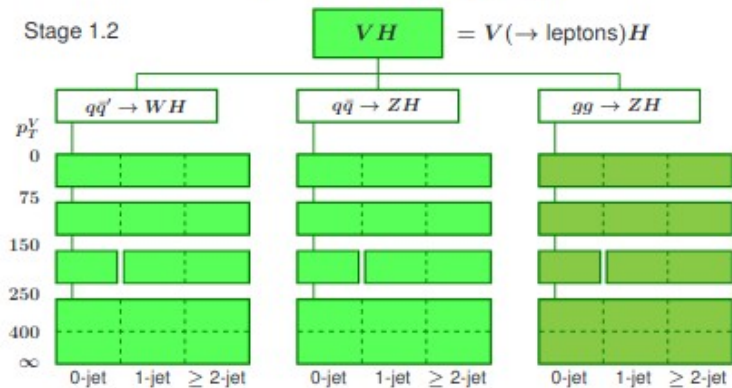
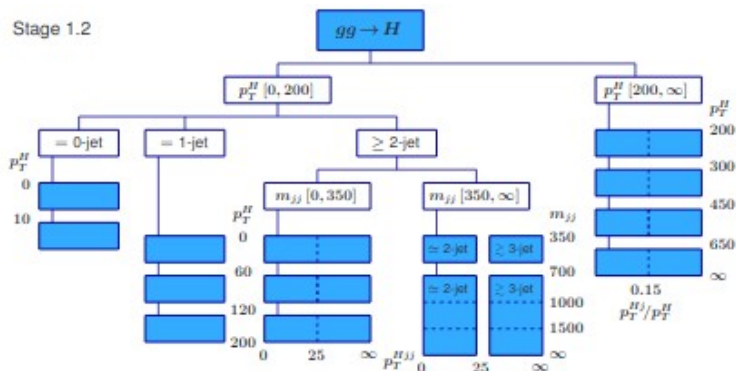
Luca Franco
(on behalf of the ATLAS collaboration)

Introduction

- Measurements with Higgs to diphoton decays:
 - Total cross section;
 - Cross section in 5 production modes;
 - **Simplified Template Cross Sections (STXS).**
- Full LHC Run 2 dataset: 139 fb^{-1} of p-p collisions at $\sqrt{s}=13 \text{ TeV}$;
- Results made public by the ATLAS collaboration in [ATLAS-CONF-2020-026](#).

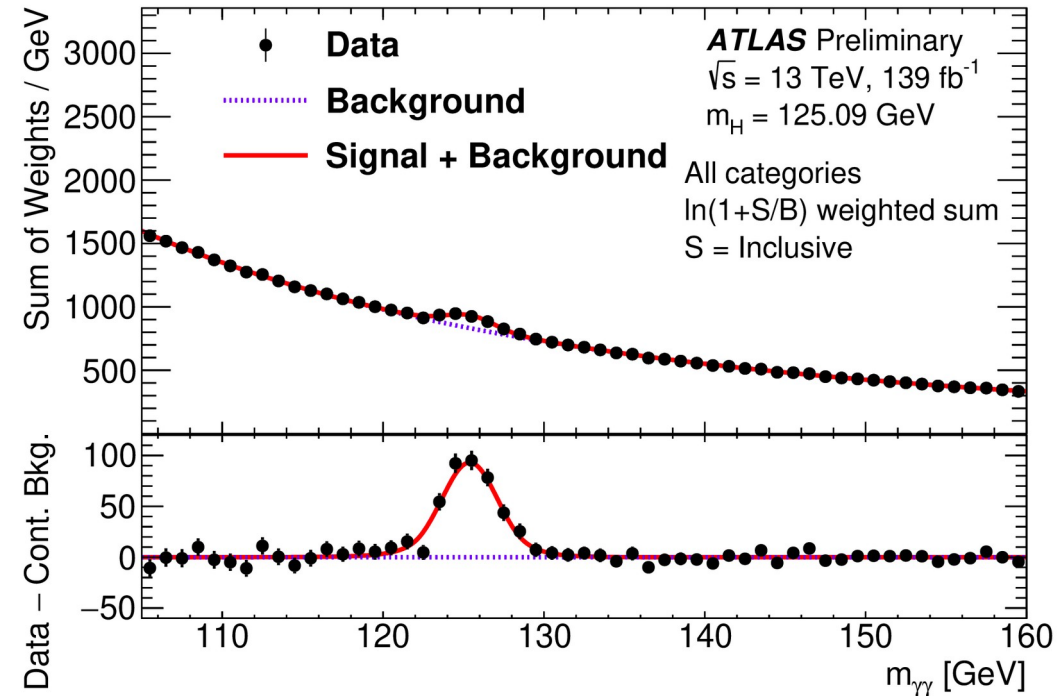
Simplified Template Cross Sections

- Measurements performed in the bins proposed by the [STXS stage 1.2 framework](#):
 - Minimize theoretical uncertainties;
 - Maximize experimental sensitivities;
 - Separately measure regions of phase space potentially sensitive to BSM effects;
 - Better combine with other decay channels.



Analysis strategy

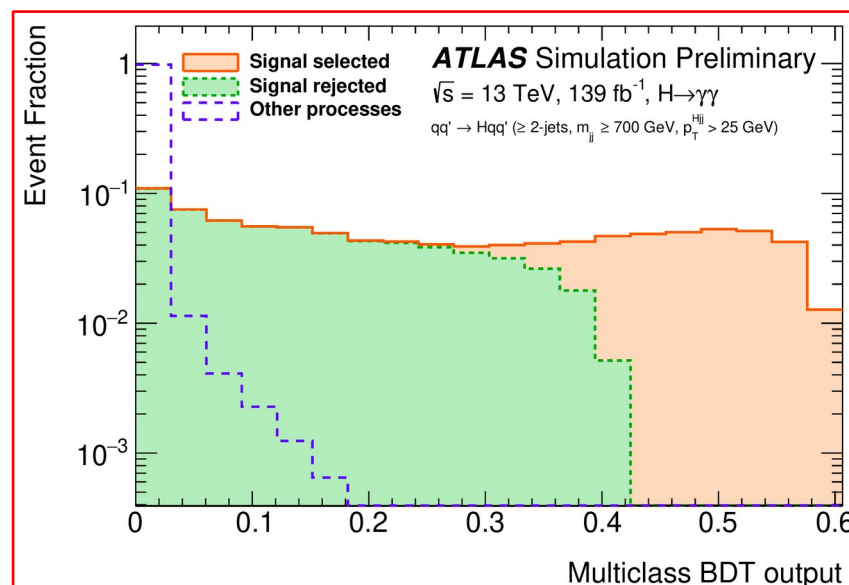
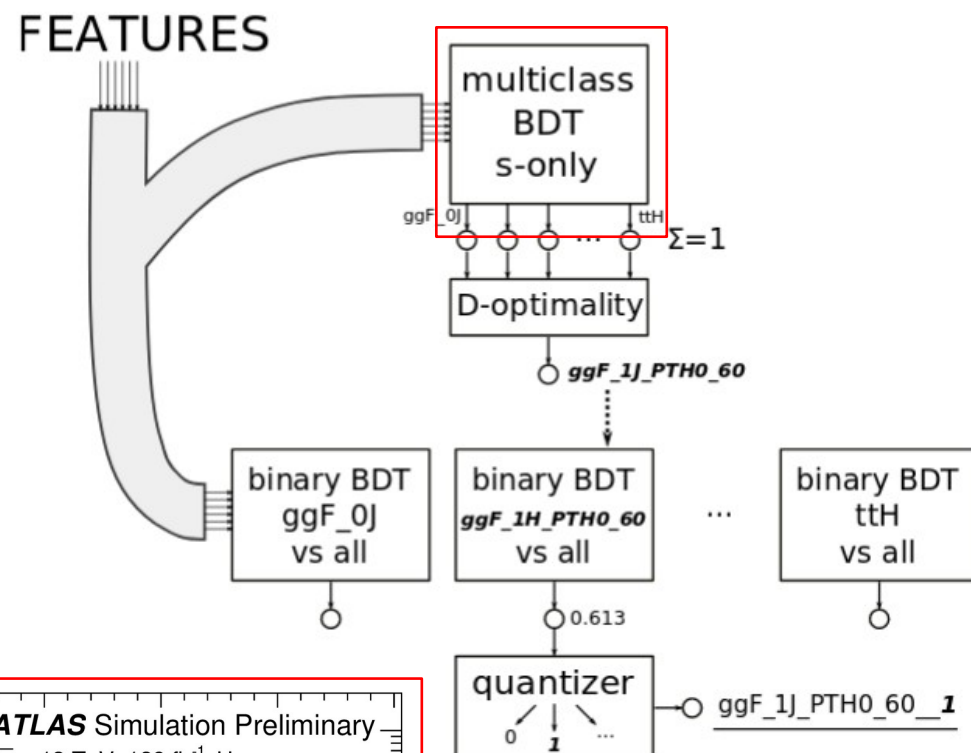
- 1) Select events with two photons compatible with the decay products of a Higgs boson;
 - 2) Classify the reconstructed events in categories following STXS definition as much as possible;
 - 3) Additional selection to separate signal from continuum background;
 - 4) Build the signal and background models using analytic functions in each category;
 - 5) Simultaneously fit the $m_{\gamma\gamma}$ distribution using the built signal+background model in each category;
- The parameters-of-interest (POIs) are $\sigma_i \times BR_{\gamma\gamma}$ normalized to the SM prediction;



- The systematic uncertainties enter the fit through constrained nuisance parameters.

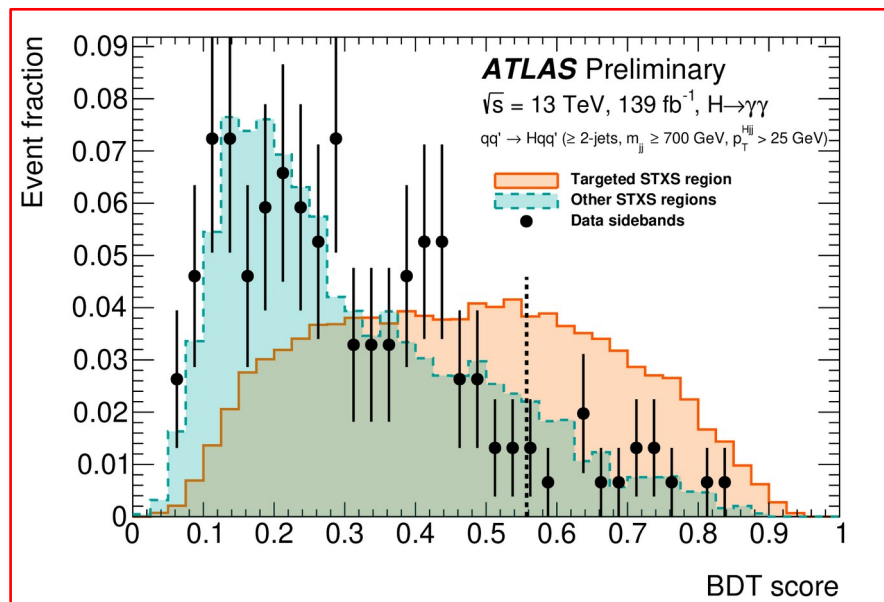
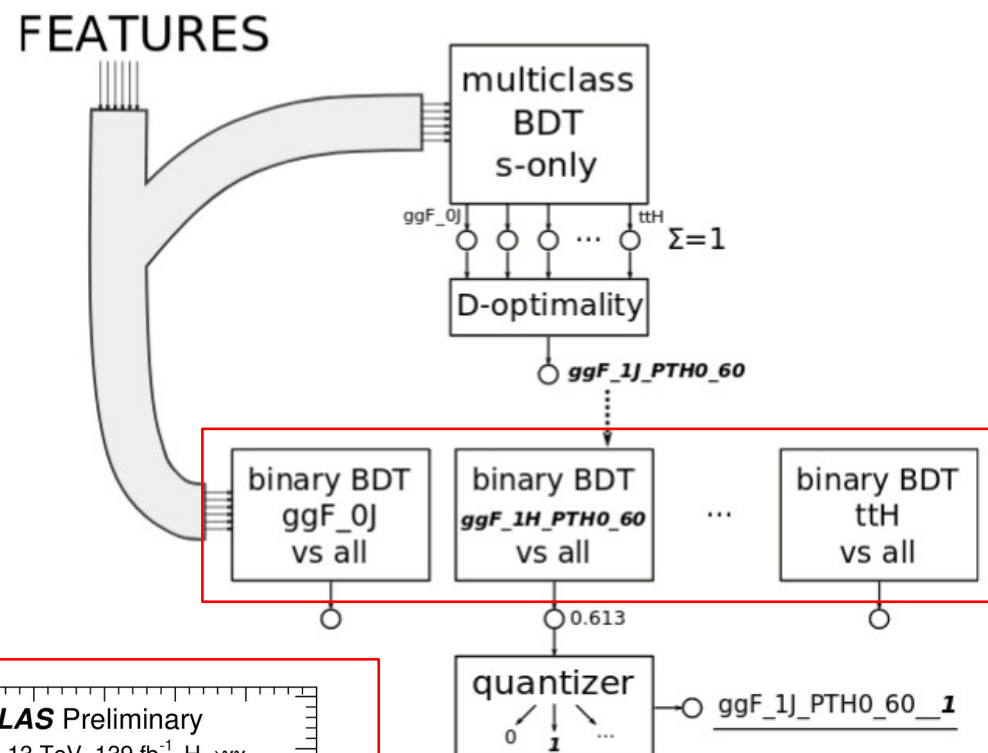
Categorization: multi-class step

- Selected events are classified into mutually exclusive categories, each targeting a STXS bin;
- Monte Carlo (MC) samples of signal processes are used to train a multiclass Boosted Decision Tree (BDT);
- Input features are variables describing the kinematic and identification properties of the reconstructed particles in the event;
- Selection on the multiclass BDT outputs to optimise the STXS errors and correlations (D-Optimality);
- At this stage, 44 Reco categories are defined, one per STXS bin.



Categorization: binary-class step

- Each reco category is further divided into multiple categories based on a binary BDT classifier.
- This binary BDT is trained to separate signal from continuum background in each class;
- Input features are variables describing the kinematic and identification properties of the reconstructed particles in the event;
- Finally, 88 reco categories are built and are used in the analysis.



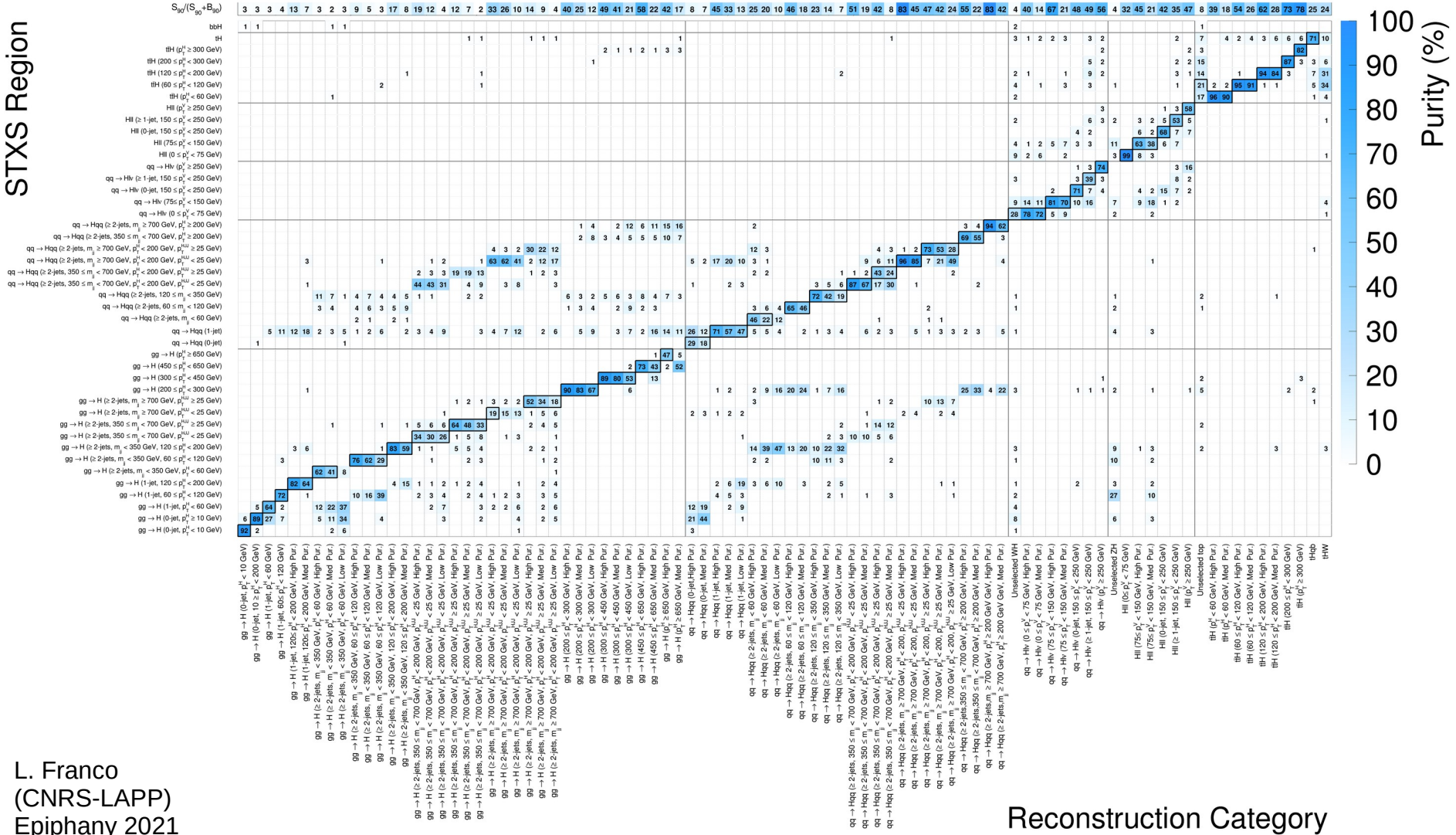
Categorization purity

- Showing correspondence between 44 truth STXS targets and 88 reconstructed categories.

STXS Region

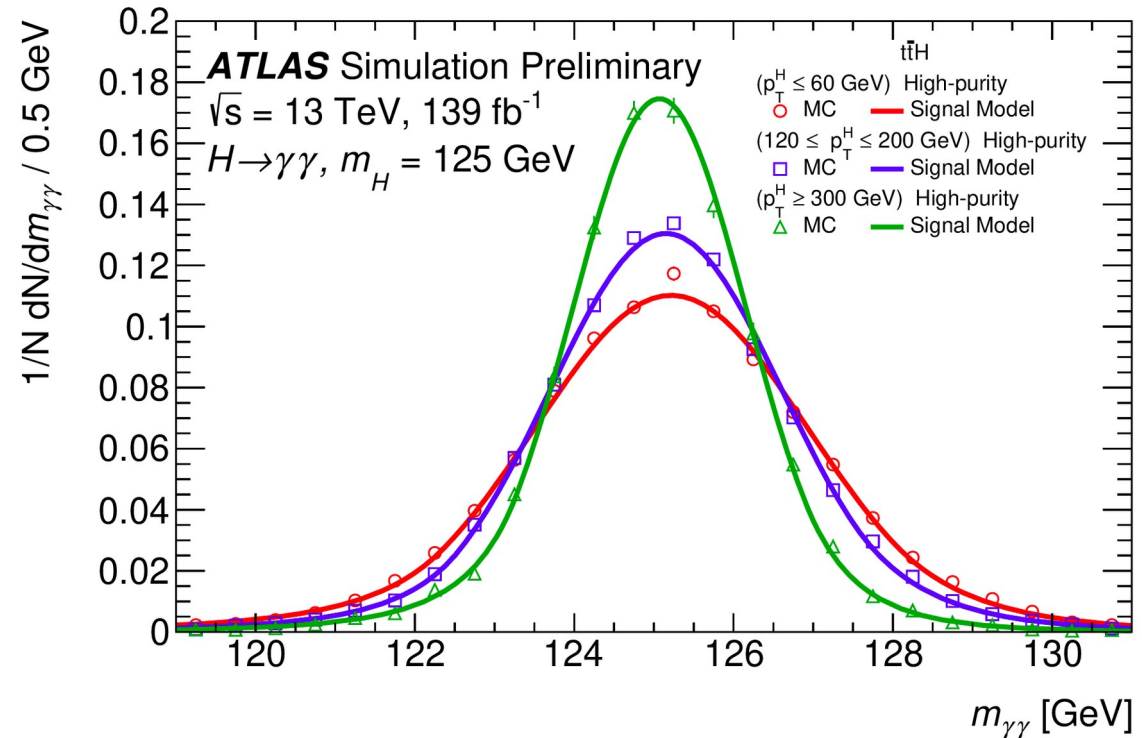
ATLAS Preliminary

$H \rightarrow \gamma\gamma$, $\sqrt{s}=13$ TeV



Signal modeling

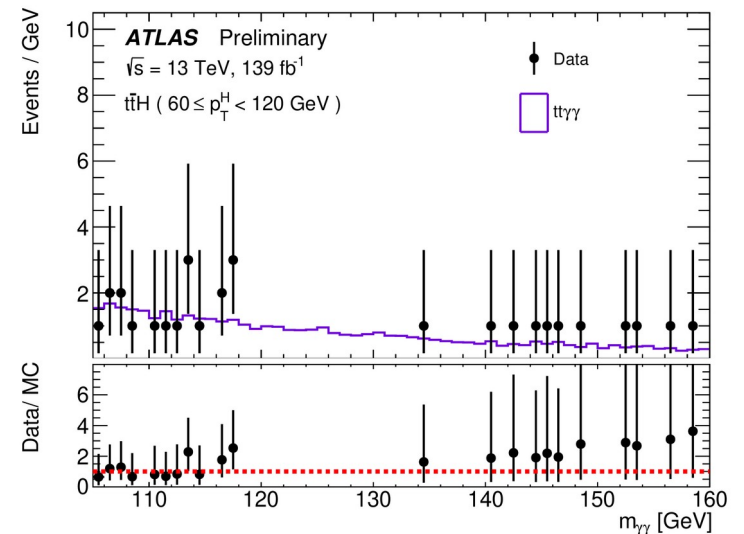
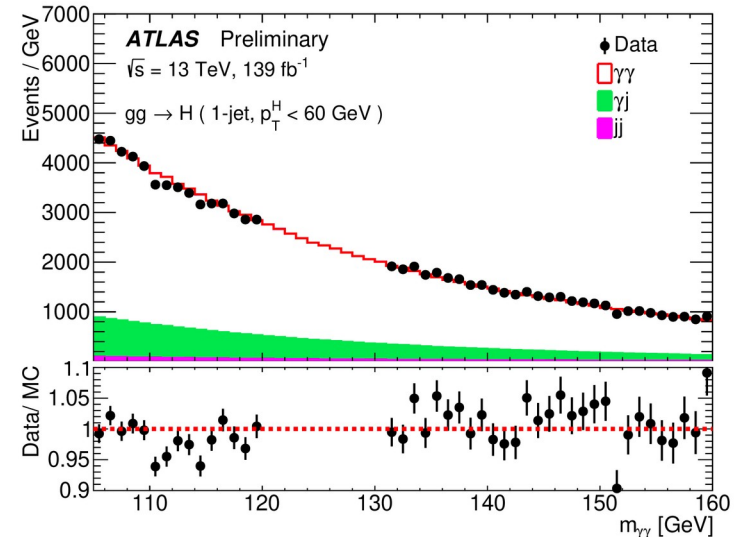
- The signal is modeled with a Double sided Crystal Ball (DSCB) function: Gaussian core, power law tails;
- The DSCB is obtained by combining different signal MC according to the expected number of events.



- DSCB is allowed to vary in the fit within the uncertainties coming from photon energy scale and resolution and Higgs boson mass measurements.

Background template construction

- For each $gg \rightarrow H$ and $qq \rightarrow Hqq$ category:
 - Estimate γ -jet, jet-jet components using data control regions;
 - Weight the $\gamma\gamma$ simulated sample to obtain $m_{\gamma\gamma}$ shape for the γ -jet and jet-jet components;
 - Combine according to their fractions to obtain the final template.
- For each VH , ttH and tH category:
 - Small contribution from γ -jet and jet-jet \rightarrow neglected;
 - Template constructed using simulated processes ($\gamma\gamma$, $V\gamma\gamma$, $t\gamma\gamma$) alone.



Choice of the background function

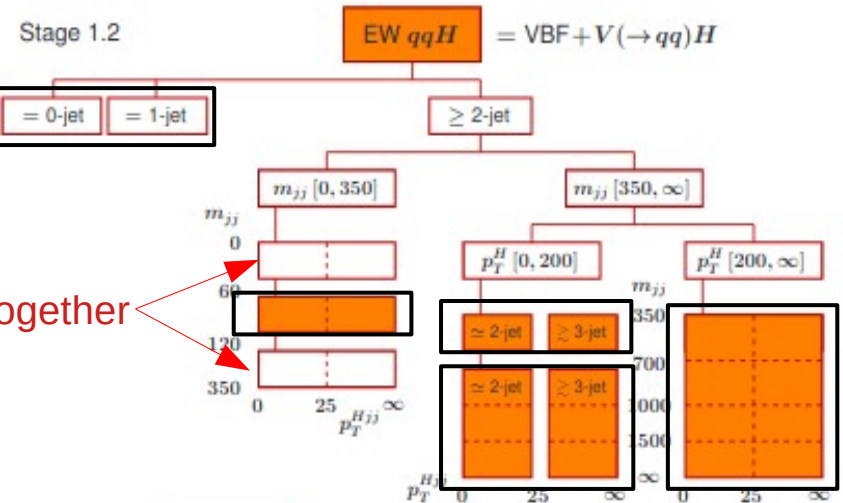
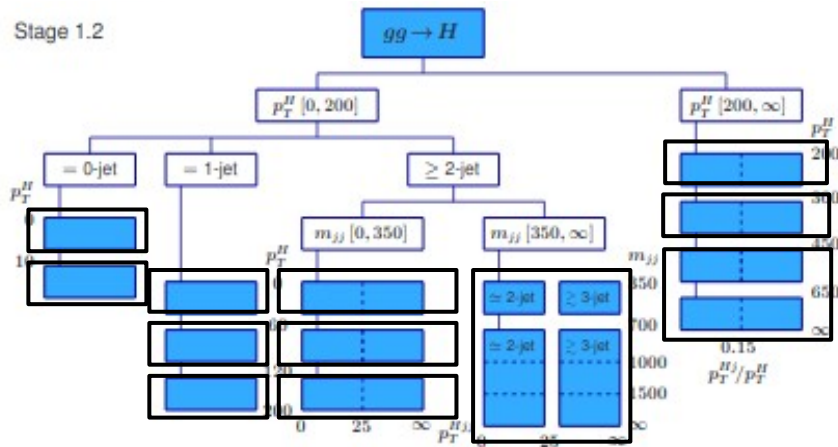
- Fitting template with Signal+Background PDF to estimate the possible bias induced by a mis-modeling of the background → this term is introduced for every category;
- For categories with high statistics (at least 100 events in data sidebands):
 - Choose the best candidate function that has minimum bias (according to **spurious signal test**).
- For categories with low statistics:
 - Consider only exponential-polynomial candidate functions;
 - Reject higher order exponential-polynomial functions according to a **Wald test** on data sidebands.
- The coefficients of these functions are free to float in the fit to the data.

Data sidebands:
 $m_{\gamma\gamma}$ in [105,120]
 or [130,160] GeV.

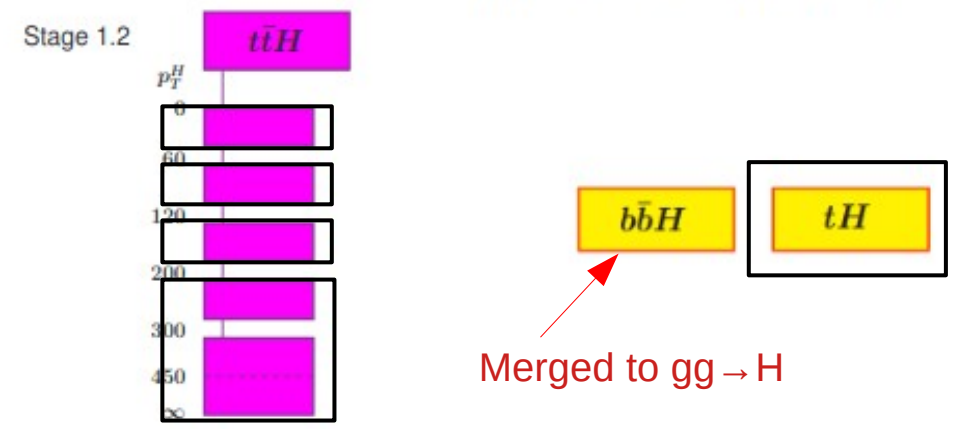
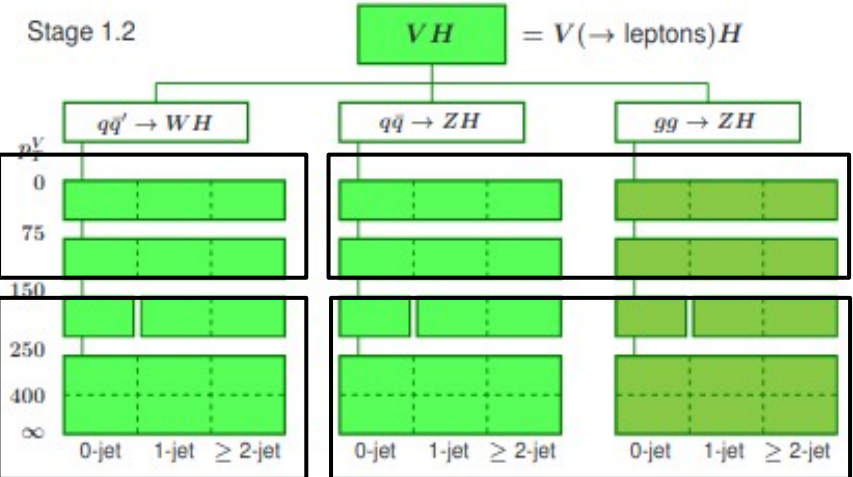
Type	Function	N_{pars}	Acronym
Power law	$m_{\gamma\gamma}^a$	1	PowerLaw
Exponential	$\exp(am_{\gamma\gamma})$	1	Exp
Exponential of second-order polynomial	$\exp(a_1 m_{\gamma\gamma} + a_2 m_{\gamma\gamma}^2)$	2	ExpPoly2
Exponential of third-order polynomial	$\exp(a_1 m_{\gamma\gamma} + a_2 m_{\gamma\gamma}^2 + a_3 m_{\gamma\gamma}^3)$	3	ExpPoly3
Bernstein polynomial	$(1-x)^n + a_1 n x (1-x)^{n-1} + \dots + a_n x^n$	$n = 1-5$	Bern1-Bern5

STXS merging

- Not enough statistical power to fit all 44 → merge down to 27 bins.



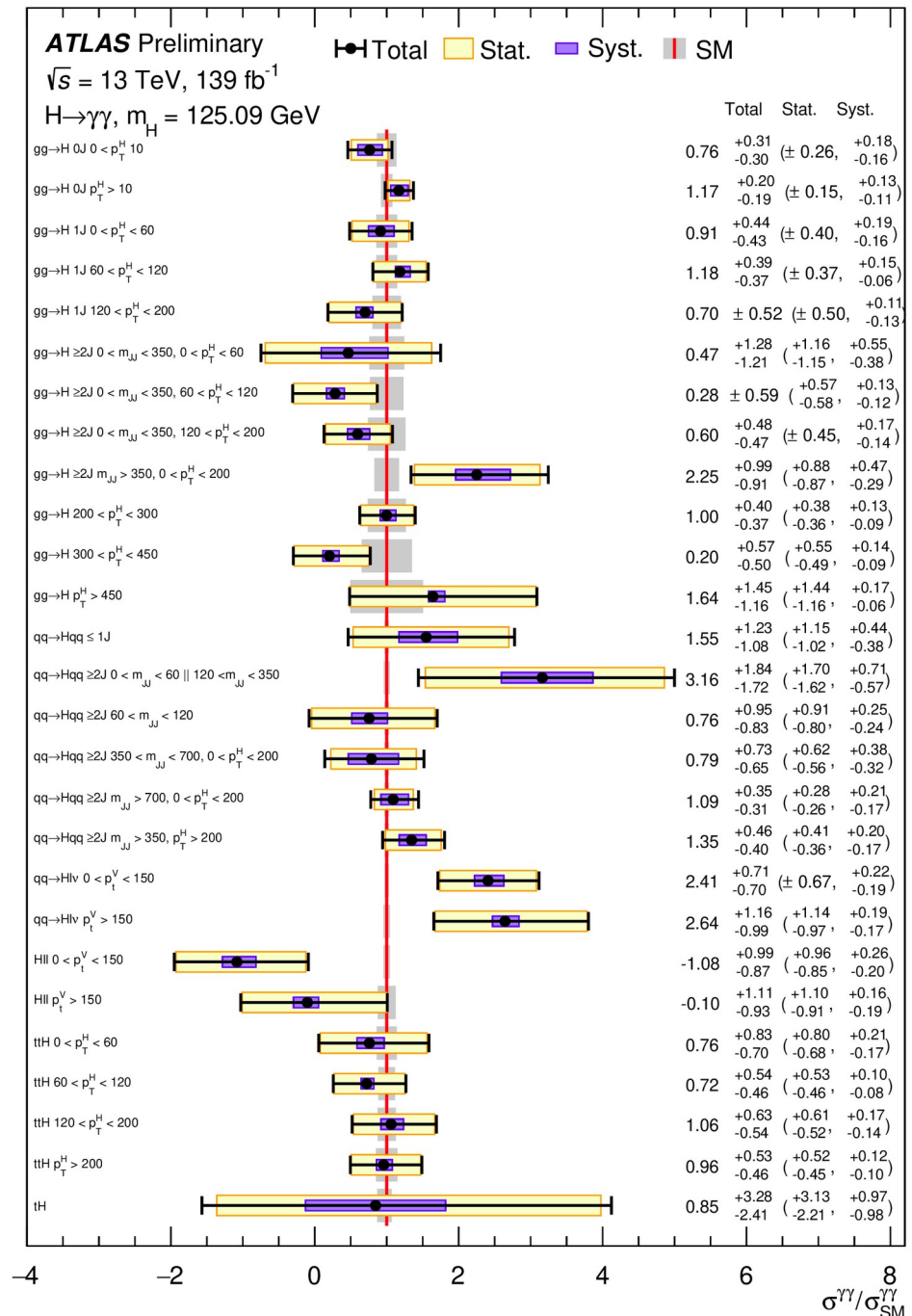
Merged together



Merged to gg -> H

Results: STXS

- Ratio to SM expectation is presented;
- Relative uncertainties from 20% to more than 100%;
- Upper limit of 8*SM prediction set on tH production;
- No significant deviation from the SM.



Next step: EFT interpretation

- The SMEFT extends the SM Lagrangian by adding new operators;
- STXS are parametrized in terms of EFT coefficients;
- Find the set of c_i to which the dataset has maximum sensitivity;
- Constrain EFT coefficients \rightarrow put limits on BSM theories.

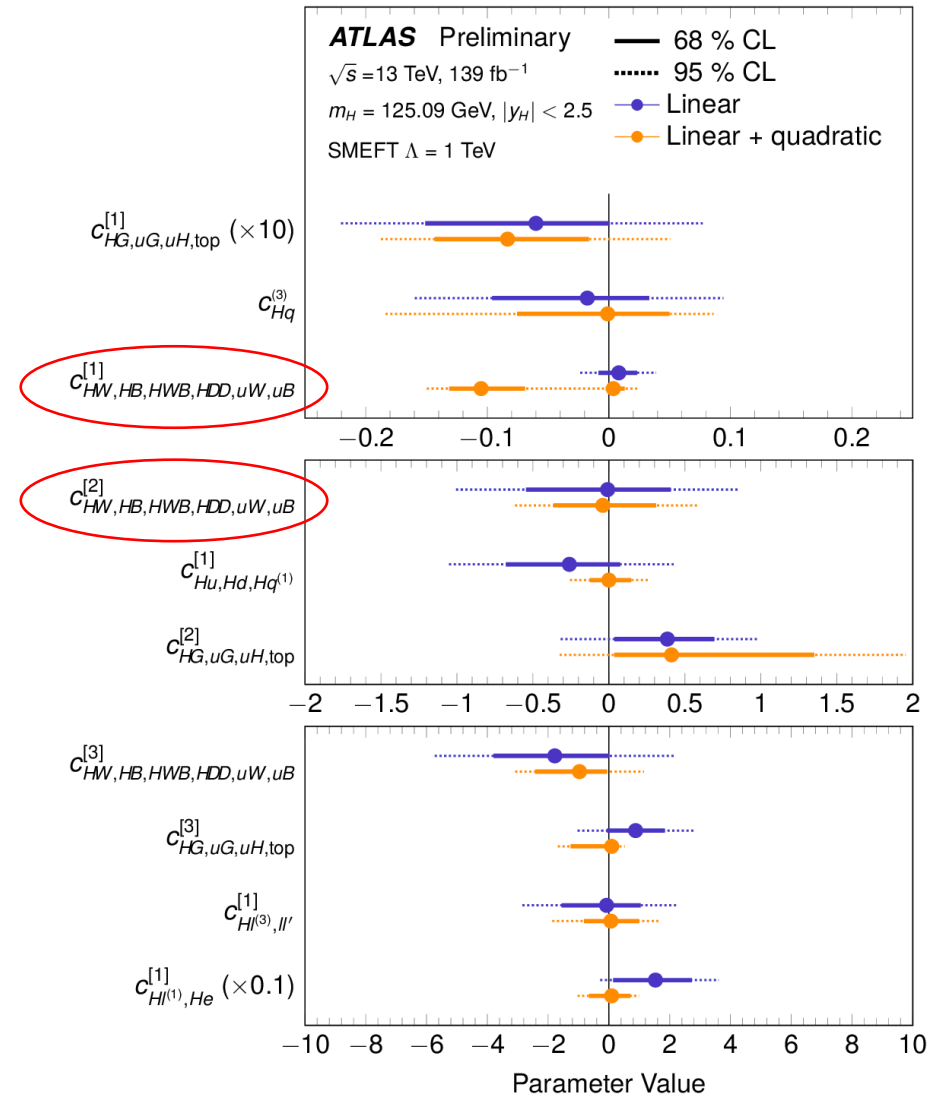
$$\mathcal{L}_{\text{EFT}} = \mathcal{L}_{\text{SM}} + \sum_i \bar{c}_i^{(6)} O_i^{(6)}$$

Red circles: $H \rightarrow \gamma\gamma$ is the most sensitive

Coefficient	Operator	Example process
c_{HDD}	$(H^\dagger D^\mu H)^* (H^\dagger D_\mu H)$	
c_{HG}	$H^\dagger H G_{\mu\nu}^A G^{A\mu\nu}$	
c_{HB}	$H^\dagger H B_{\mu\nu} B^{\mu\nu}$	
c_{HW}	$H^\dagger H W_{\mu\nu}^I W^{I\mu\nu}$	
c_{HWB}	$H^\dagger \tau^I H W_{\mu\nu}^I B^{\mu\nu}$	
c_{eH}	$(H^\dagger H)(\bar{l}_p e_r H)$	
$c_{Hl}^{(1)}$	$(H^\dagger i \overleftrightarrow{D}_\mu H)(\bar{l}_p \gamma^\mu l_r)$	
c_{uG}	$(\bar{q}_p \sigma^{\mu\nu} T^A u_r) \tilde{H} G_{\mu\nu}^A$	
c_{uW}	$(\bar{q}_p \sigma^{\mu\nu} u_r) \tau^I \tilde{H} W_{\mu\nu}^I$	
c_{uB}	$(\bar{q}_p \sigma^{\mu\nu} u_r) \tilde{H} B_{\mu\nu}$	

EFT results from Higgs combination

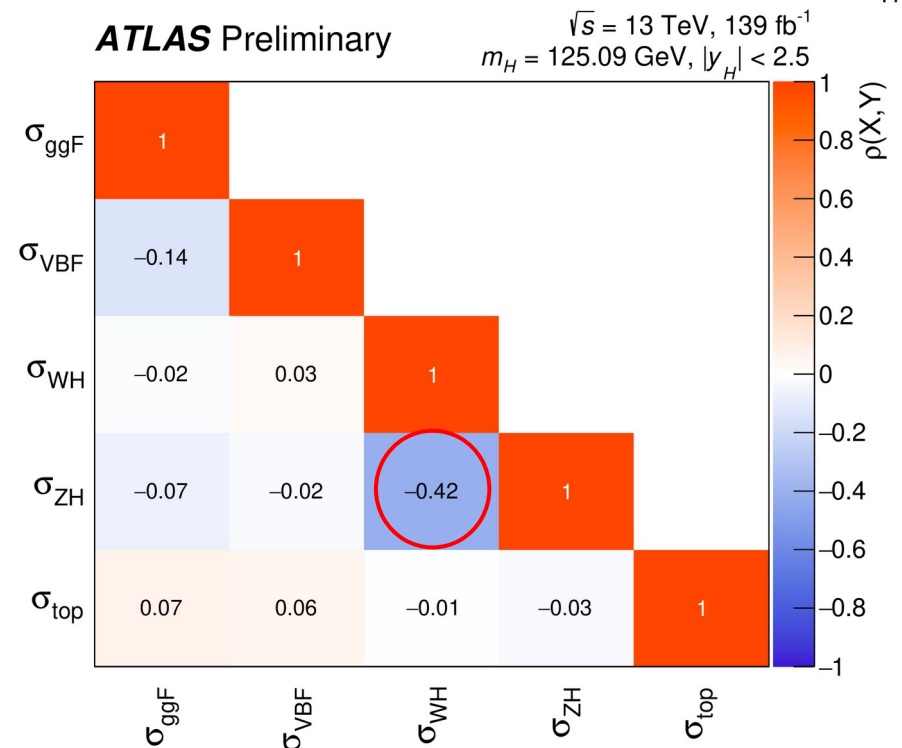
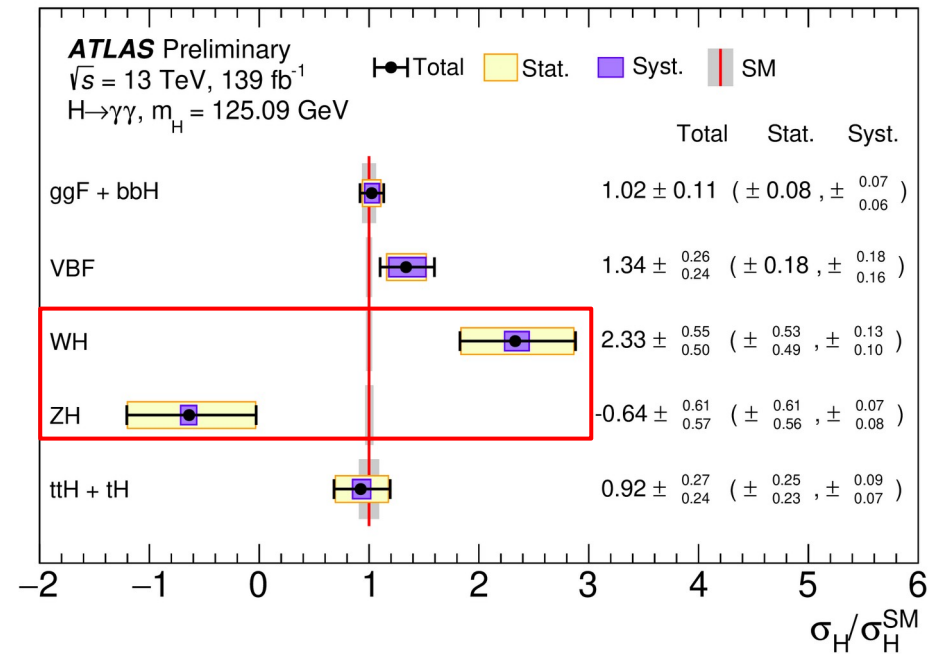
- Combination of $H \rightarrow \gamma\gamma$, $H \rightarrow b\bar{b}$ (VH only), $H \rightarrow ZZ^* \rightarrow 4l$ analyses;
- Results published by the collaboration in [ATLAS-CONF-2020-053](#);
- Measuring combination of c_i to which we are most sensitive;
- SMEFT linearized model and model including quadratic terms;
- No significant deviation from the SM.



$H \rightarrow \gamma\gamma$ leading the sensitivity

Conclusions

- Measurements of the properties of the Higgs boson production at $\sqrt{s}=13$ TeV in the diphoton decay channel;
- STXS results of the combination with other decay channels interpreted through EFT;
- Legacy paper foreseen in 2021 with improvements:
 - New categorization \rightarrow to reduce correlation between ZH and WH;
 - Background smoothing \rightarrow to reduce spurious signal bias;
 - $H \rightarrow \gamma\gamma$ standalone interpretation with EFT and kappa frameworks.
- Very important test for the SM prediction \rightarrow no hint of new physics observed.





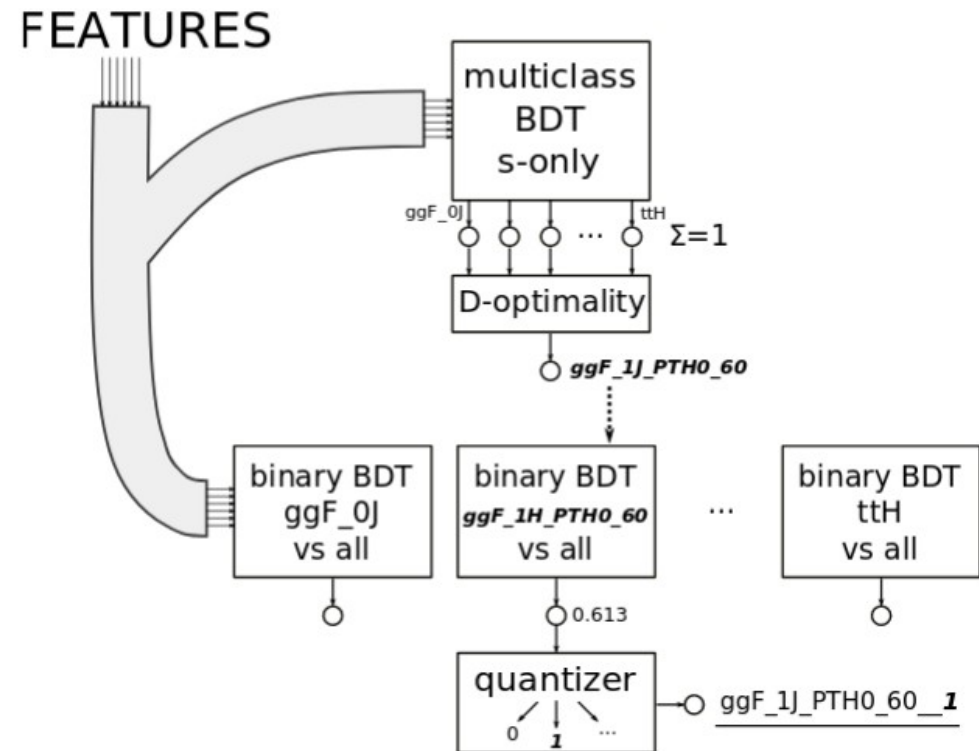
BACK-UP

Event selection

- Reconstructed photon candidates must satisfy a preselection:
 - $p_T > 25$ GeV;
 - $|\eta| < 2.37$ (with $1.37 < |\eta| < 1.52$ excluded);
 - Loose identification requirement;
- Diphoton selection:
 - Two highest p_T preselected photons;
 - Vertex selected using a Neural Network;
- Final event selection:
 - Tight identification requirement and well isolated photons;
 - $p_T^{Y1}/m_{YY} > 0.35$ and $p_T^{Y2}/m_{YY} > 0.25$
 - $105 < m_{YY} < 160$ GeV

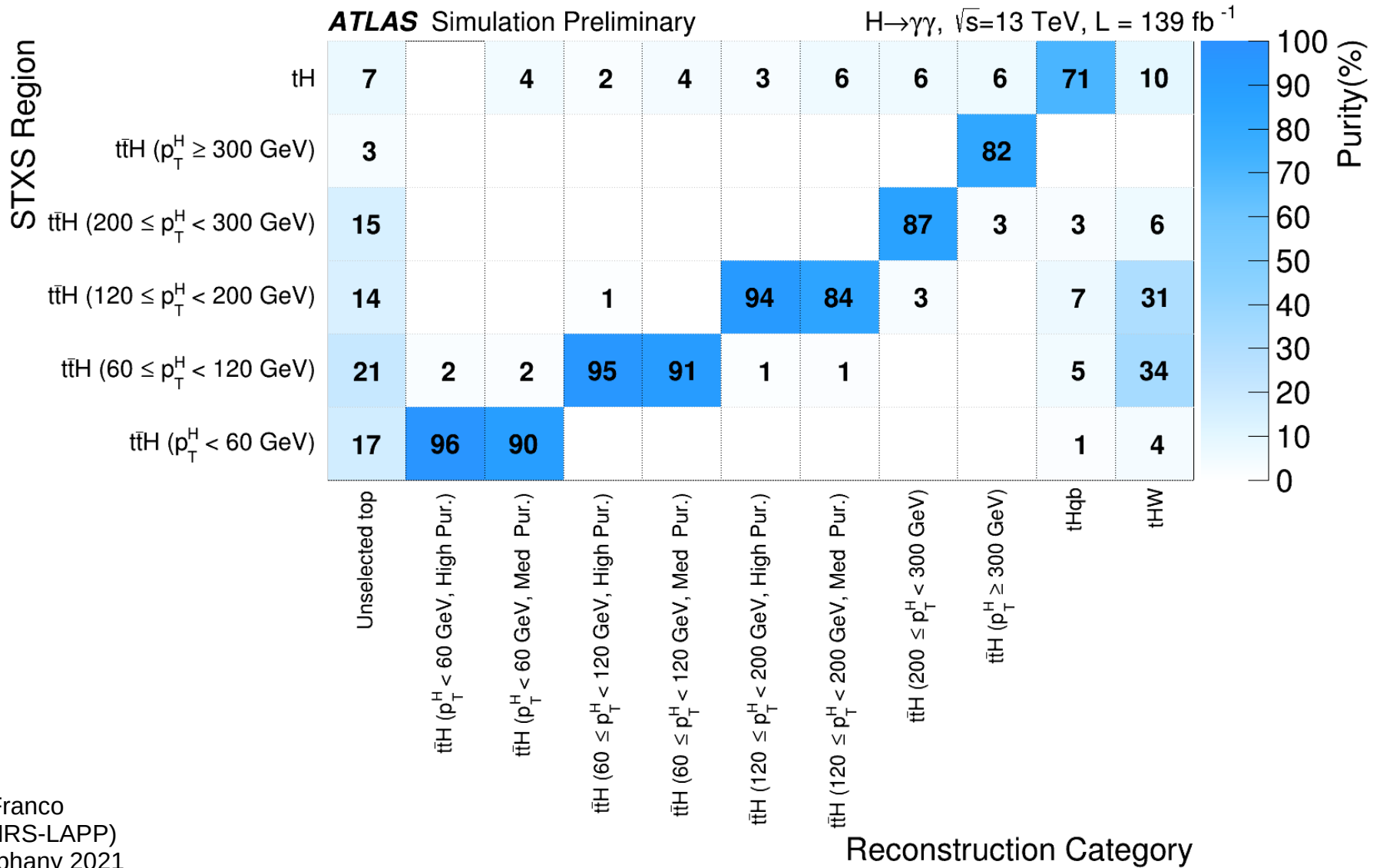
Categorization: summary

- IDEA: Targets the full STXS granularity simultaneously. Optimized for the determinant of the covariance matrix of the results, it takes into account both errors and correlations of the fit.
- PROCEDURE:
 - Train a multiclass BDT over 44 STXS truth bins (signal only) with high level and top-reco variables;
 - D-optimality: weight the multiclass outputs and classify events in 44 reco classes;
 - In each reco class, train a binary BDT (signal vs backgrounds) with high level and top-reco variables;
 - Build 88 categories with significance scans over BDT outputs



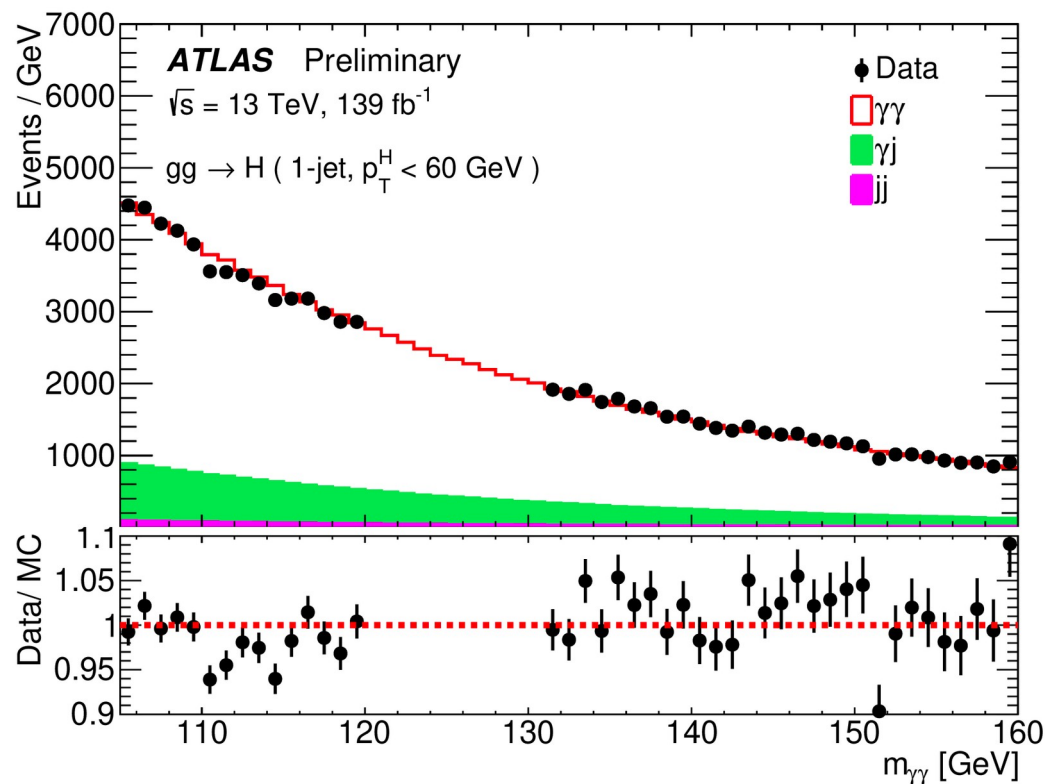
Categorization purity: ttH, tH

- Correspondence between ttH, tH STXS bins and reconstructed categories targeting them.



Background modeling: summary

- Construct background templates using MC or data control regions;
- Fit the obtained templates with a set of functions, choose the one that:
 - Gives the smallest bias (spurious signal test);
 - Doesn't overfit the template (Wald test).



Spurious signal test

- In each category, a signal+background fit is performed over the background-only template and the value of the fitted signal yield S_{spur} is reported;
- Each candidate function is tested independently;
- The function passes the test if:
 - $|S_{\text{spur}}| < 10\%$ of expected signal yield;
 - Or $|S_{\text{spur}}| < 20\%$ of the statistical uncertainty of the fitted (expected) signal yield.
- Additionally, the fit is required to bring a χ^2 probability of at least 1%;
- If more than one candidate passes for a category, the one with less degrees of freedom is chosen.

Type	Function	N_{pars}	Acronym
Power law	$m_{\gamma\gamma}^a$	1	PowerLaw
Exponential	$\exp(am_{\gamma\gamma})$	1	Exp
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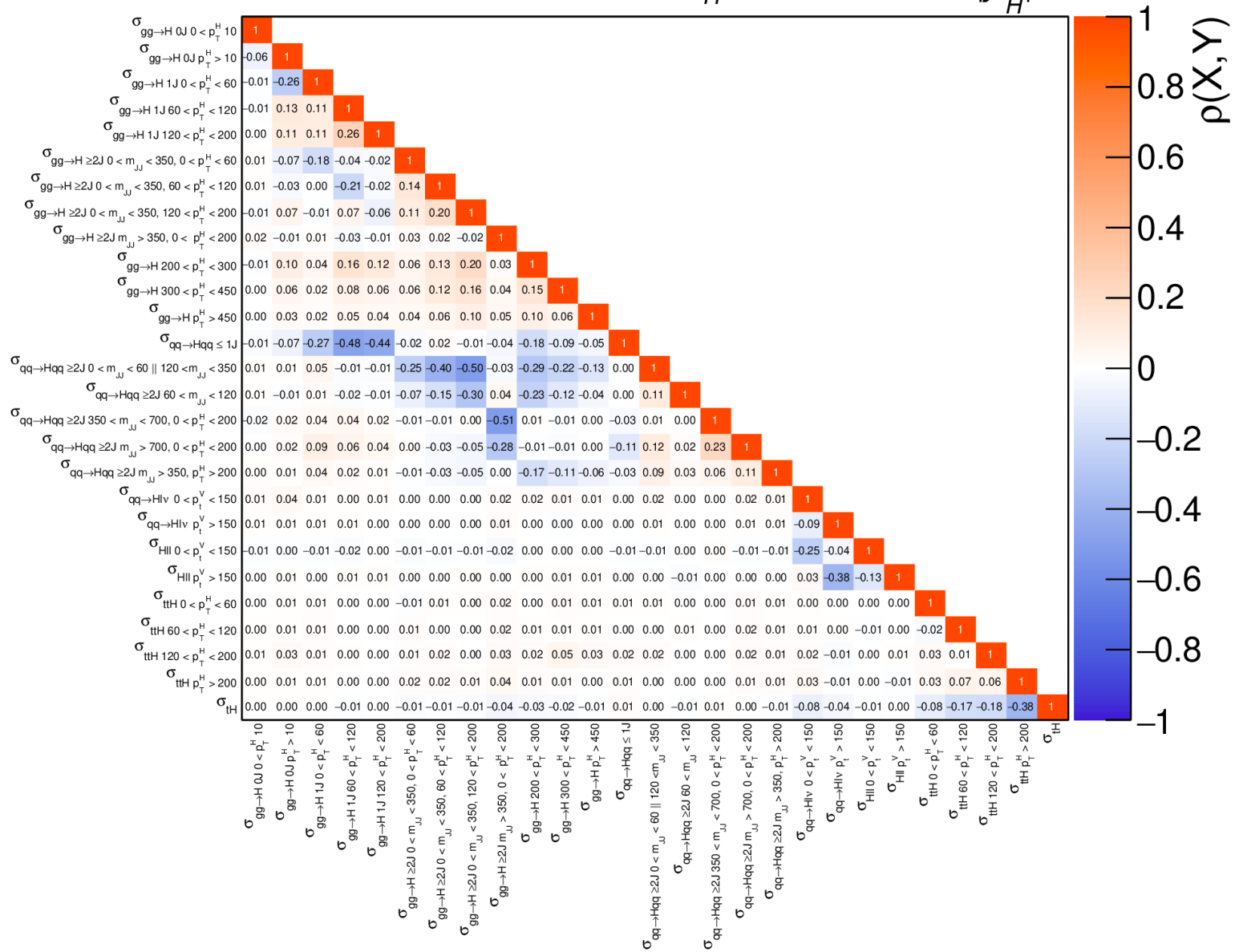
Wald test

- For categories with less than 100 data events in the control region, a Wald test is performed in order to choose the analytical function modeling the background in the category;
- Candidate background functions are limited to Exp, ExpPoly2 and ExpPoly3, in order to avoid unphysical fits due to large statistical fluctuations;
- The quantity q_{12} is computed, where L_1 and L_2 are the maximum likelihood values corresponding to the use of Exp and ExpPoly2 in the fit;
- The ExpPoly2 model is chosen if the p-value associated to q_{12} is less than 0.05;
- Similarly, the ExpPoly3 form is chosen over ExpPoly2 if the p-value for the corresponding Wald test is 0.05 or less.

$$q_{12} = -2 \log \frac{L_1}{L_2}$$

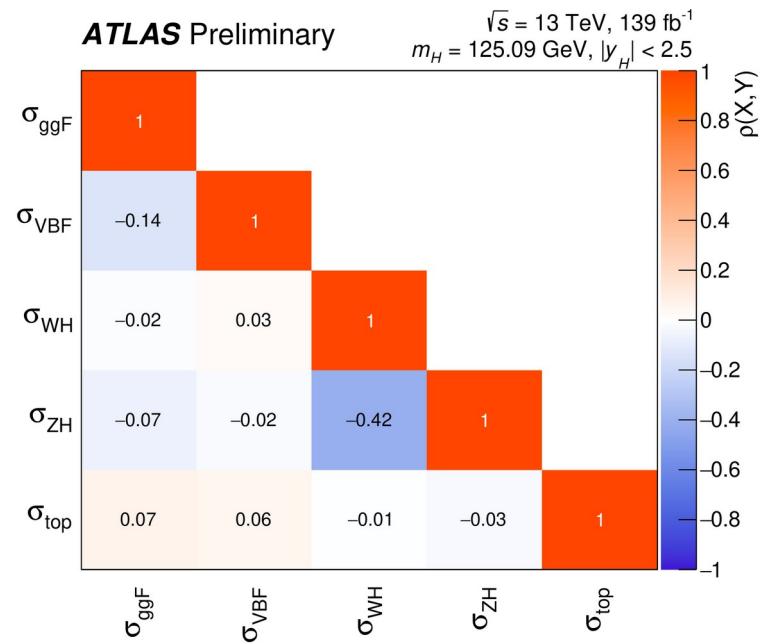
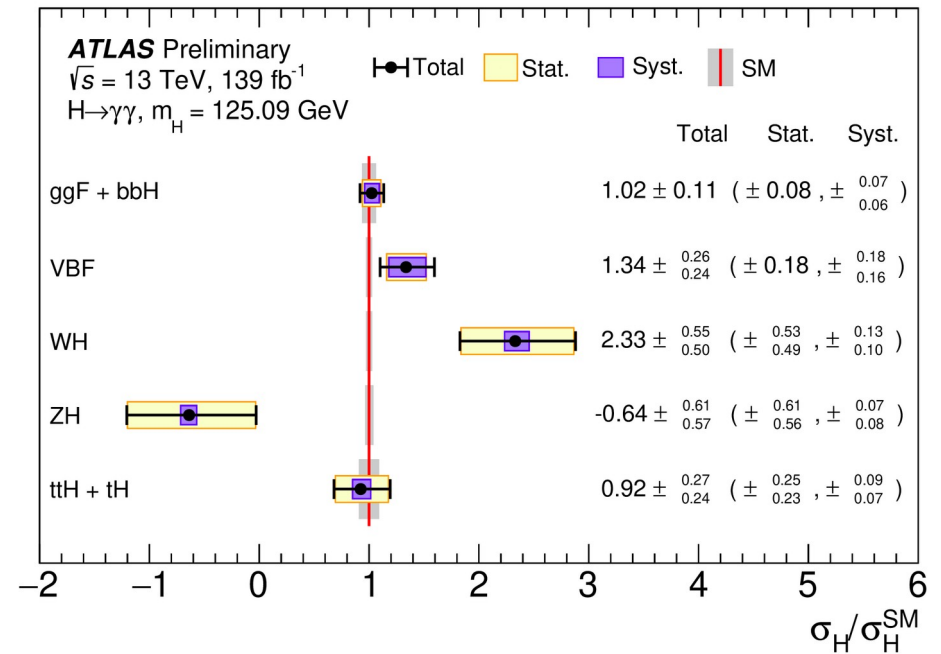
STXS observed correlations

ATLAS Preliminary $\sqrt{s} = 13 \text{ TeV}, 139 \text{ fb}^{-1}$
 $m_H = 125.09 \text{ GeV}, |y_H| < 2.5$



Results: Production mode XS

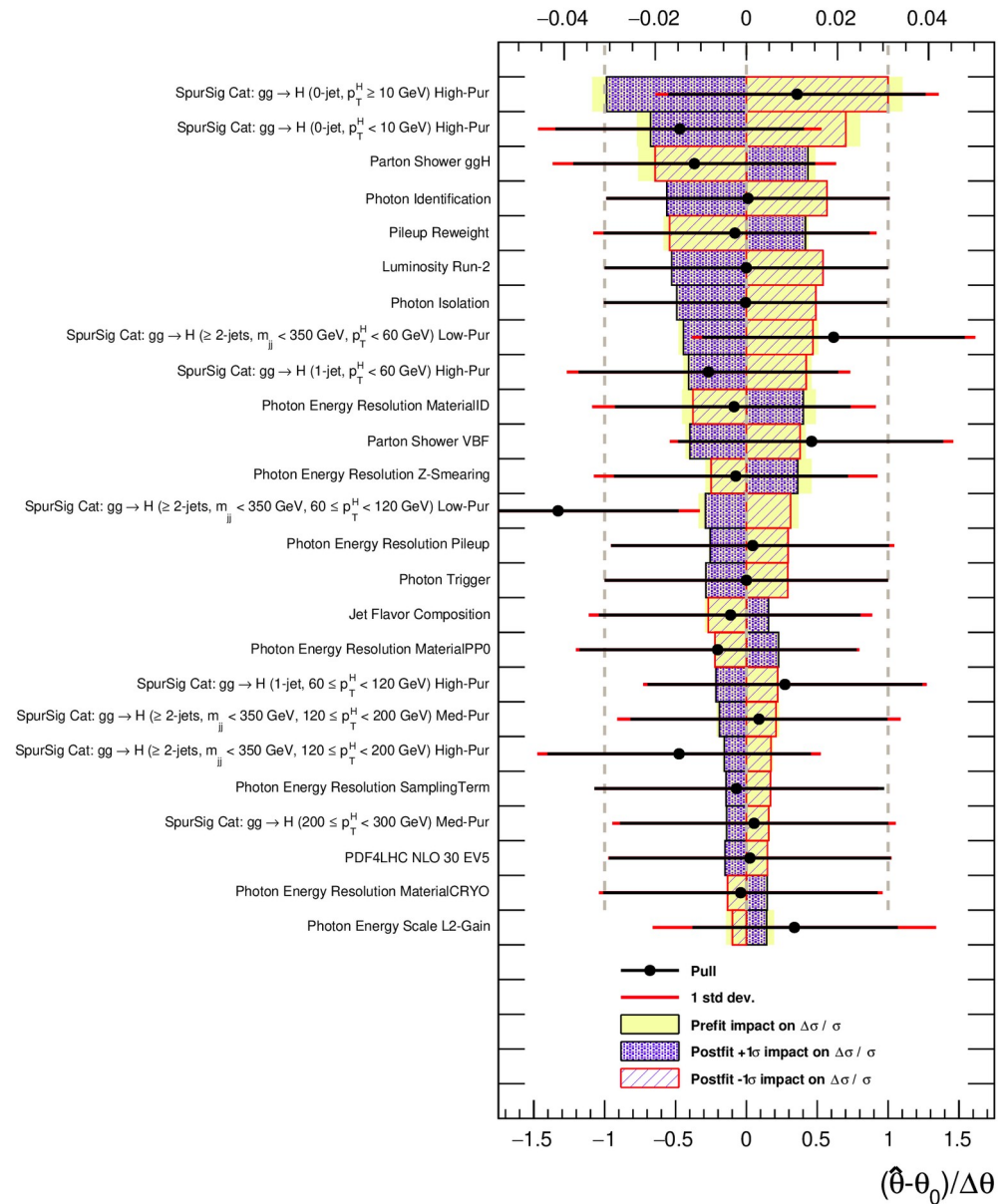
- Production modes xs are measured;
- Ratio to SM expectation is presented;
- Smaller (larger) than expected yield for ZH (WH);
- -42% correlation between ZH and WH;
- Good compatibility with the SM (p-value of 3%).



Main systematics

- Theoretical: perturbative QCD calculations, modeling of parton shower, choices of the parton distribution functions and value of α_S , modeling of heavy flavor quark production in non-ttH processes.
- Experimental (shape): photon energy scale (<0.3%) and resolution (between 1% and 8%);
- Experimental (yield): Among many, the uncertainties with the largest variations in signal yields are the pileup modeling uncertainty (up to 7%), jet flavor tagging uncertainty (up to 5%), and jet energy resolution uncertainty (up to 4%).
- Background modeling: Bias induced by the choice of the analytical function (spurious signal) range from 10% to 99% of the stat uncertainty in that category.

ATLAS Preliminary $ggF \Delta\sigma / \sigma$



EFT: choice of measured parameters

- It's not possible to fit/constrain all the $c_i \rightarrow$ must find the optimal set through a Principal Component Analysis;
- C_{STXS} is the SM expected covariance matrix of the measurement; P is the linearised parametrisation matrix;
- C_{EFT}^{-1} represents (Gaussian approx.) the Fisher information matrix of its SMEFT re-parametrisation;
- Eigenvalue decomposition of $C_{\text{EFT}}^{-1} \rightarrow$ eigenvectors corresponding to the most sensitive directions.

